

<b>Notice of References Cited</b>	Application/Control No. 10/549,862		Applicant(s)/Patent Under Reexamination HUIZING ET AL.	
	Examiner John B. Sotomayor		Art Unit 3662	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,333,077 A	06-1982	Teilhet, Michel	342/52
*	B	US-4,622,554 A	11-1986	Gellekink et al.	342/67
*	C	US-2004/0145511 A1	07-2004	Klausing et al.	342/052
*	D	US-7,030,775 B2	04-2006	Sekiguchi, Hiroyuki	340/903
*	E	US-2007/0057837 A1	03-2007	Huizing et al.	342/052
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2004086083 A1	10-2004	World Intellect	HUIZING et al.	G01S 13/86
	O	JP 2005005978 A	01-2005	Japan	YOSHIDA, ICHIRO	H04N 07/18
	P	JP 2005156199 A	06-2005	Japan	OTSUKA et al.	G01B 11/00
	Q	JP 2005216200 A	08-2005	Japan	IGARASHI et al.	G08G 01/16
	R	JP 2005215964 A	08-2005	Japan	MORI et al.	G08G 01/16
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.